

INTRODUCTION

- 1. The contents is subject to change without notice. Please exchange the specification sheets regarding the product's warranty.
- 2. This sheet is not intended to guarantee or provide an approval of implementation of industrial patents.
- 3. We have prepared this sheet as carefully as possible. If you find it incomplete or unsatisfactory in any respect, We would welcome your comments.

This product complies with RoHS Directive.

This Product supplied (and any technical information furnished, if any) by Seiko Epson Corporation shall not be used for the development and manufacture of weapon of mass destruction or for other military purposes. Making available such products and technology to any third party who may use such products or technologies for the said purposes are also prohibited.

This product listed here is designed as components or parts for electronics equipment in general consumer use. We do not expect that any of these products would be incorporated or otherwise used as a component or part for the equipment, which requires an extra high reliability, such as satellite, rocket and other space systems, and medical equipment, the functional purpose of which is to keep life.

Product No. / Model

The product No. of this crystal unit is Q24FA20H0039600. The model is FA-20H.

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MSL

MSL level 1

[1] Absolute maximum ratings

No.	Parameter	Rating value	Note
1	Storage temperature	-40 °C to +125 °C	Suppose to be within CI std. at +25 °C \pm 3 °C

[2] Operating range

	_	~	Value				
No.	Parameter	Symbol	Min.	Тур.	Max.		
1	Operating temperature	T_use	-30 °C	_	+85 °C		
2	Level of drive	DL	10 µW		100 μW		

[3] Electrical characteristics

No.	Parameter	Symbol	Standard	Conditions
1	Nominal frequency	f	40 MHz	Fundamental
2	Frequency tolerance	f_tol	$\pm 7 \times 10^{-6}$	CL = 8 pF Ta = +25 °C±3 °C Drive level : 100 μ W Not include aging
3	Motional resistance	R1	40 ΩMax.	π circuit JIS C6701 Drive level : 100 μ W Ta=-30 °C to +85 °C
4	Shunt capacitance	C0	2 pF Max	
5	Frequency versus temperature characteristics	f_tem	$\pm 10 \times 10^{-6}$	Ta = -30 °C to +85 °C (1 × 10 ⁻⁶ at +25 °C \pm 3 °C) Drive level : 100 µW
6	Isolation resistance	IR	500 MΩ Min.	DC 100V \times 60 sec. between each terminals
7	Frequency aging	f_age	$\pm 1 \times 10^{-6}$ / year	$Ta = +25 \text{ °C} \pm 3 \text{ °C}$ Drive level : 100 μ W

[4] Environmental and mechanical characteristics

Item No.3 to No.6 shall be tested after following pre conditioning.

Pre conditioning : Test crystal must be leaving in room temperature for 2h to 24h after reflow $\times 3$. (The company evaluation condition : We evaluate it by the following examination item and examination condition.)

		Value *1 *2	Test Conditions			
No.	Item	$\Delta f / f [1 \times 10^{-6}]$	Test Conditions			
1	Drop	(2) ± 2	150g dummy Jig (EPSON TOYOCOM			
			Standard) drop from 1500 mm height on			
			the Concrete 3 directions 10 times			
2	Vibration	$(2) \qquad \pm 2$	10Hz to 55 Hz amplitude 0.75 mm			
			55Hz to 500Hz acceleration 98 m/s ²			
			$10\text{Hz} \rightarrow 500\text{Hz} \rightarrow 10\text{Hz} \ 15\text{min./cycle}$			
			6 h (2 hours , 3 directions)			
3	High temperature storage	(1) ± 2	+85°C × 1 000 h			
4	Low temperature storage	(1) ± 2	$-40^{\circ}C \times 1\ 000\ h$			
5	Temperature cycle	(1) ± 2	$-40^{\circ}C \leftrightarrow +85^{\circ}C$			
			30 minutes at each temp. 100 cycle			
6	Temperature humidity	(1) ± 2	$+85^{\circ}C \times 85\%RH \times 1\ 000\ h$			
	storage					
7	Resistance to soldering heat	± 2	For convention reflow soldering furnace			
			(3 times)			
8	Substrate bending	No peeling-off at a soldered	Bend width reaches 3 mm and hold for			
		part	$5 \text{ s} \pm 1 \text{ s} \times 1$ time Ref. IEC 60068-2-21			
9	Shear	No peeling-off at a soldered	10 N press for 10 s \pm 1 s			
		part	Ref. IEC 60068-2-21			
10	Pull – off	No peeling-off at a soldered	÷			
		part	Ref. IEC 60068-2-21			
11	Solder ability	Terminals must be 95%	Dip termination into solder bath at			
		covered	$+230 ^{\circ}\text{C} \pm 10 ^{\circ}\text{C} \text{ for 5 s}$			
		With fresh solder.	(Using Rosin Flux)			

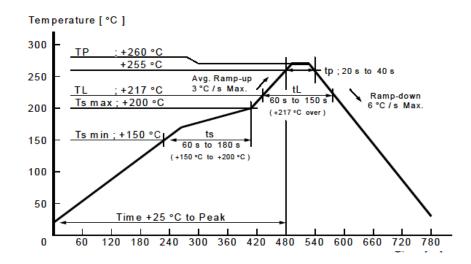
< Notes >

1. Item No.1 to No.11 resistance at before above tests should be less than ± 20 % or less than $\pm 10\Omega$.

2. *1 each test done independently.

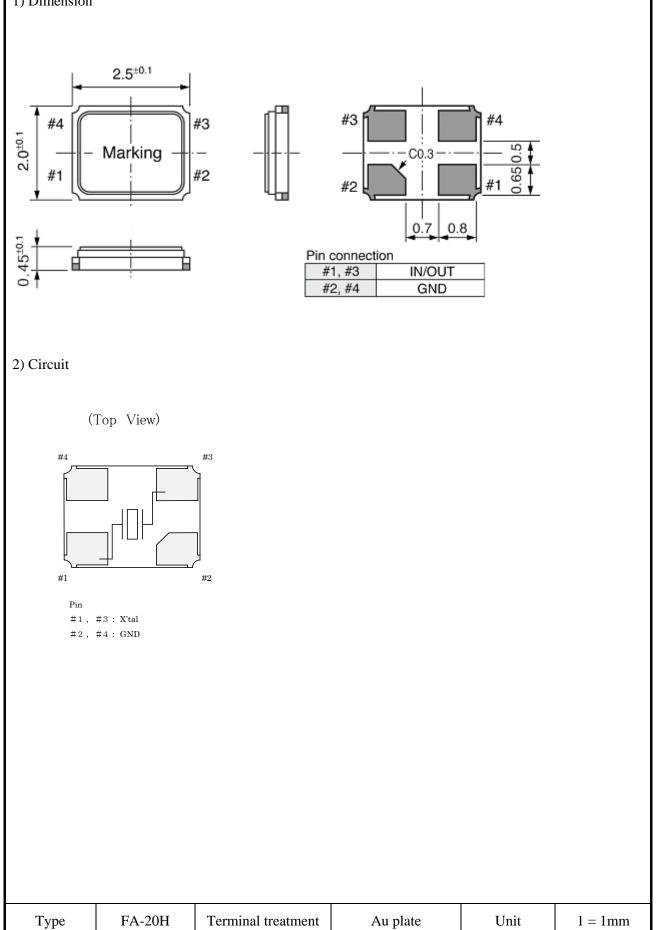
3. *2 measuring 24 h later leaving in room temperature after each test.

Reflow condition (follow to IPC / JEDEC J-STD-020C)

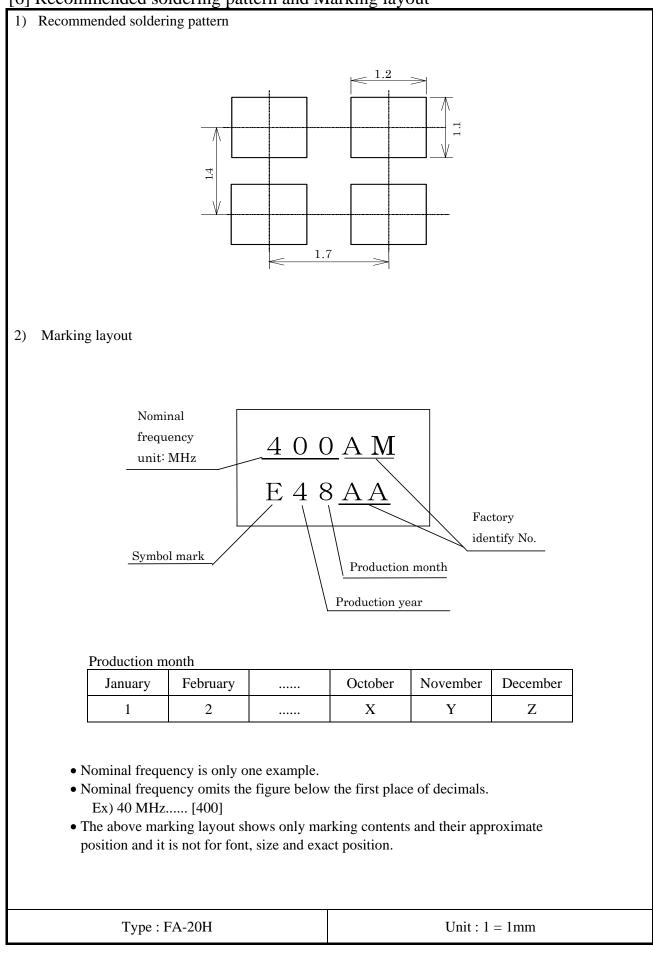


[5] Dimensions and Circuit

1) Dimension



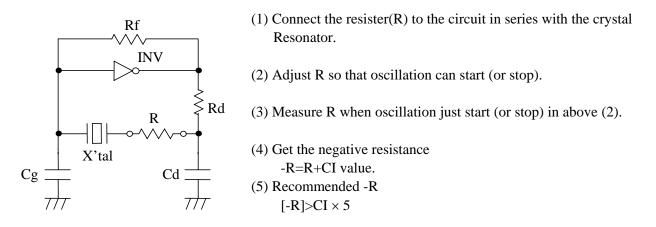
[6] Recommended soldering pattern and Marking layout



[7] Notes

- 1. Max three (3) times re-flow is allowed. Its recommended to manually solder when not enough/no solder detected.(Using soldering iron at +350 °C Max × within 5 seconds)
- 2. Patterning on a board should follow our company recommended pattern.
- 3. Applying excessive excitation force to the crystal resonator may cause deterioration damage.
- 4. Start up time of oscillation may be increased or no oscillation may occur unless adequate negative resistance is allocated in the oscillation circuit In order to avoid this, please provide enough negative resistance to the circuit design.

How to check the negative resistance



- 5. It is recommended to do patterning to the oscillator as short as possible. Abnormal oscillation may happened if the line is too long.
- 6. To avoid malfunction, no pattern across or near the crystal is allowed. Solder paste should be less than 100μm thickness.
- 7. Few data or readings taken at user side may be different from our company's data. Confirmation of the different value is necessary before application.
- 8. Too much exciting shock or vibration may cause deterioration on damage. The product may damage depends on the condition such as a shock in assembly machinery. Please check your process condition in advance to minimize and maintain the shock level.
- 9. Condensation may occur when products are used/stored under remarkable temperature change.
- 10. Please refer to packing specification for the storage method and packing standard.
- 11. This product may be affected to ultrasonic cleaning. It is depends on the cleaning conditions (Cleaning machine type/power/time/content/position etc.). The warranty will not cover any damage due to this type of usage. Check conditions prior to use.

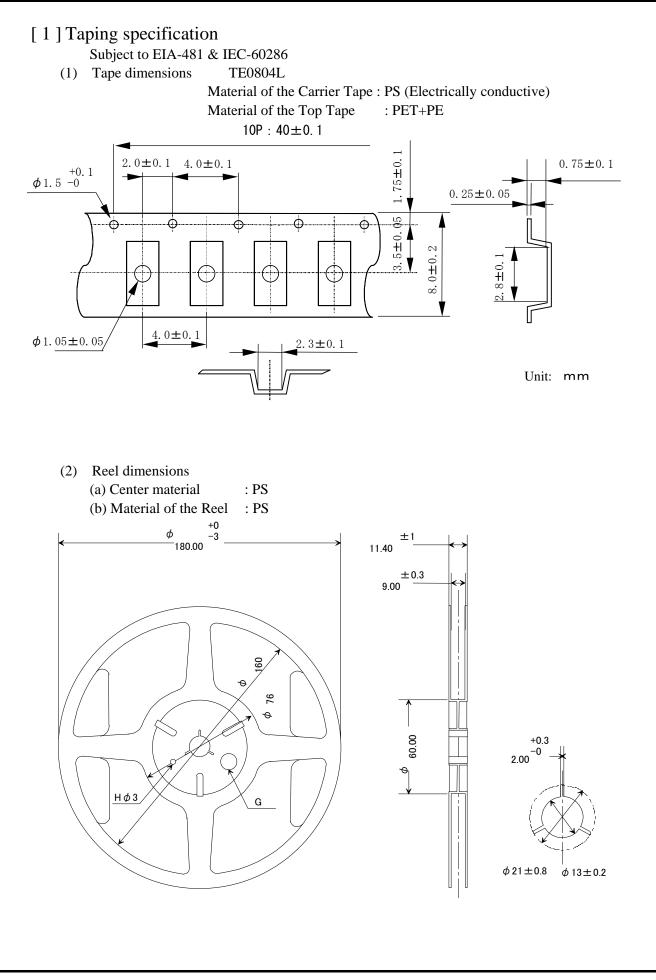
TAPING SPECIFICATION

1. APPLICATION

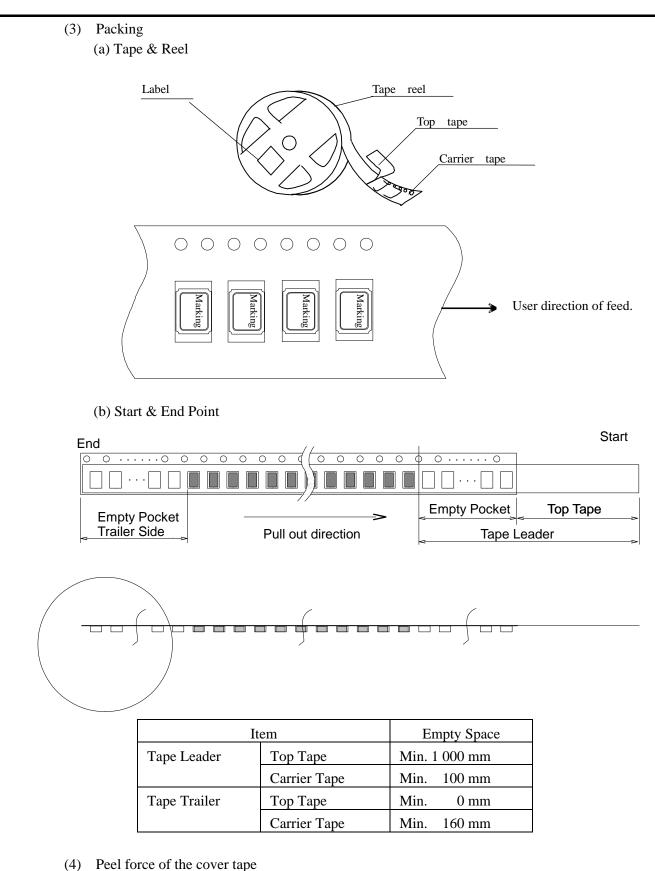
This document is applicable to FA-20H

2. CONTENTS

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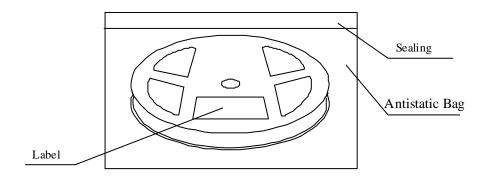
P. 1



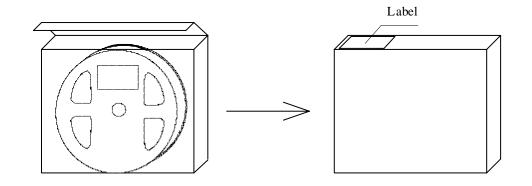
- (1) angle : cover tape during peel off and the direction of unreeling shall be 165° to 180° .
- 2 peel speed : 300 mm / min.
- ③ strength : 0.1 to 1 N.

[2] Inner Carton

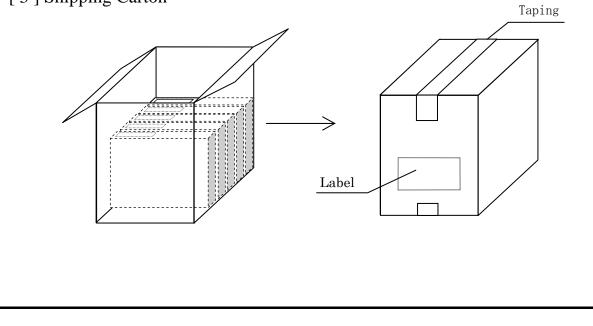
a) Packing to antistatic bag



b) Packing to inner carton



[3] Shipping Carton



[4] Marking

- (1) Reel marking
 - Reel marking shall consist of :
 - 1) Parts name
 - 2) Quantity
 - 3) Manufacturing Date or symbol
 - 4) Manufacturer's Date or symbol
 - 5) Others (if necessary)
- (2) Inner carton marking
 - Same as Reel marking.
- (3) Shipping carton marking
 - Shipping carton marking shall consist of :
 - 1) Parts name
 - 2) Quantity

[5] Quantity

• 3 000 pcs./reel

[6] Storage environment

- (1) Before open the packing, we recommend to keep less than +30 °C and 85 % RH of Humidity, and to use it less than 6 months after delivery.
- (2) We recommend to open Package in immediately before use. After open Package, We recommend to keeps less than 6 month. No need dry air before soldering work if it is less than temperature +30 °C, 85 humidity %RH.
- (3) Not to expose the sun.
- (4) Not to storage with some erosive chemicals.
- (5) Nothing is allowed to put on the reel or carton to prevent mechanical damage.

[7] Handling

To handle with care to prevent the damage of tape, reel and products.

<u>No. IA-0601-01-AIE-4</u>

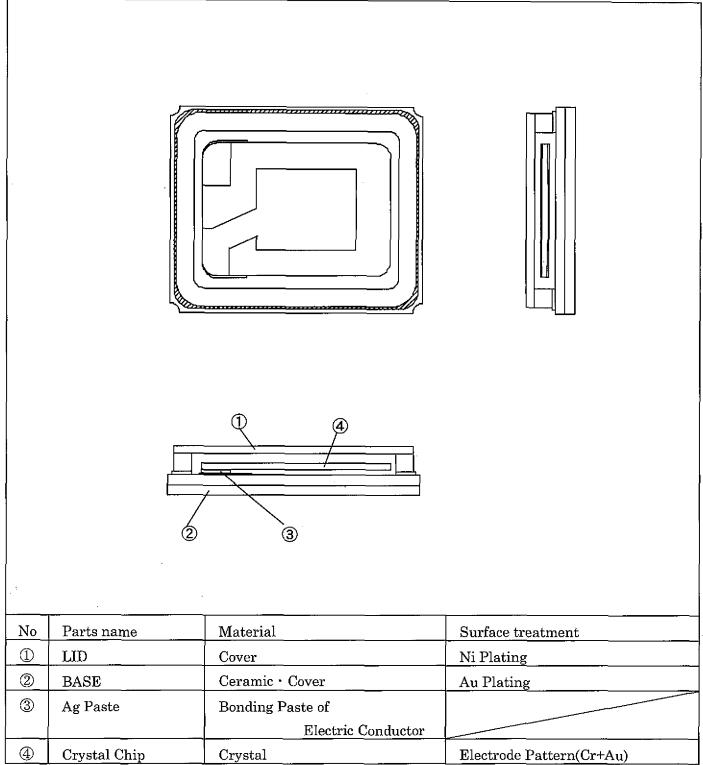
SMD TYPE AT STRIP CRYSTAL : FA-20H / 206

12.09.14

Manufact	turing p	process shart	No.	Section	Standard	Inspection, Control items	Inspection method	Instrument	Record
Ci	rystal bl	lock	1	Inspecting section.	Purchasing specification	Size.	Sampling.	Measure.	In-coming inspection
	<u>γ</u>			(INA plant)	Incoming inspection standard	Outer appearance.	11	Visual inspection.	data sheet.
						Inner appearance.	"	Visual inspection.	
	\bigcirc	In-coming inspection	1'	Inspecting section.	"	Size.	Sampling.	Comparator.	
	T			(INA plant)		Outer appearance.	п	Micro scope.	
	2	Wafer cutting	2	Inspecting section.	Manufacturing instruction sheet	Cut angle.	Sampling.	X-ray raido grafic.	Process data sheet.
				(Ina / China /Thailand Plant)		Wafer thickness.	П	Comparator.	
	3	Wafer lapping	3	Producing section.	н	Frequency.	Sampling.	Frequency counter.	11
				(Ina / China /Thailand Plant)		Wafer thickness.	11	Comparator.	
ramic base	4	Chip cutting	4	Producing section.	н	Size.	Sampling.	Comparator.	11
∇_{i}				(Ina / China /Thailand Plant)					
	5	Etching	5	Producing section.	"	Frequency.	Sampling.	Comparator.	П
1 In-coming		-		(Ina / China /Thailand Plant)		Outer appearance.		Micro scope.	
inspection	6	Deposition	6	Producing section.	н	Frequency.	Sampling.	Comparator.	Н
	_			(Ina / Thailand / Malaysia Plant)		Outer appearance.		Micro scope.	
				•					
Lid	7	Mounting	7	Producing section.	"	Outer appearance.	All insprcion.	Micro scope.	
∇	Ī	5		(Ina / Thailand / Malaysia Plant)				·····	
In-coming	(8)	Frequency adjustment	8	Producing section.	"	Frequency.	Sampling.	Frequency counter.	11
1'> inspection	Ĭ			(Ina / Thailand / Malaysia Plant)					
Y	_		9	Producing section.	"	Outer appearance.	Sampling.	Micro scope.	11
	(9)	Welding		(Ina / Thailand / Malaysia Plant)					
	Ē	0	10	Producing section.	"	Airtightness check.	All insprcion.	Leak tester.	
	<u>ه</u>	Leak test		(Ina / Thailand / Malaysia Plant)					
			11	Producing section.	"	Outer appearance.	Sampling.	Micro scope.	11
	m	Marking		(Ina / Thailand / Malaysia Plant)					
	Ĭ	5	12	Producing section.	"	Crystal impedance.	All insprcion.	Inspectional machine	
	$\overline{\mathbb{Q}}$	Characteristic inspection		(Ina / Thailand / Malaysia Plant)		Frequency.	11	"]
	Ÿ			,, ,, ,, ,, ,		Insulation resistance.	"	"	
						Temp. characteristic.	Sampling.	"	
							j		
	3	Out-going inspection	13	Inspecting section.	Out-going inspection standard	Crystal impedance.	Sampling.	Inspection M/C.	Out-going inspection
		J J		(Ina / Thailand / Malaysia Plant)	JJ	Frequency.	//	11	data sheet.
				· · · · · · · · · · · · · · · · · · ·		Insulation resistance.			
						Outer appearance.		Micro scope.	
	1 (14)	Taping	14	Producing section.	Manufacturing instruction sheet	Tape-peel strength.	Sampling.		Process data sheet.
	Ĭ	. ~ 3	'	(Ina / Thailand / Malaysia Plant)		l see poor da ongan	lesbing.		
	 (15)	Packing	15	Product control section.	Manufacturing instruction sheet	Address.			Delivery slip.
	U	r achilig	'	(Ina / Thailand / Malaysia Plant)	Packing instruction sheet	Quantity.	_	_	
				(ina / mailanu / Malaysia Flant)	racking instruction sheet		=		



No. : A-0601-AE-1



RELIABILITY TEST DATA Product Name : FA-20H

The Company evaluation condition

Wee	evaluate environmenta	1 and mechanical characteristics by the followin		6014-1	-001E
	a nanana kan sanana di basi na maga ki an sa ki sa ki sa ki sa kanana da maka kanana kanana kanana kanana kana K		VALUE *1 *2	TEST	FAIL
No.	ITEM	TEST CONDITIONS	Δf/f	Qty	Qty
	×.		[1 × 10 ⁻⁶]	[n]	[n]
		150g dummy Jig (EPSON TOYOCOM	*3		
1	Shock	Standard)	± 2	22	0
		drop from 1500 mm height on the Concrete			
		10 Hz to 55 Hz amplitude 0.75 mm	*3		
2	Vibration	55 Hz to 500 Hz acceleration 98 m/s ²	± 2	22	- 0
2	VIOLADOR	$10 \text{ Hz} \rightarrow 500 \text{ Hz} \rightarrow 10 \text{ Hz}$ 15 min / cycle	T Z	44	, U
	· · ·	$6 h (2 h \times 3 \text{ directions})$			
Partificação Sector	Usah topporature		*3		
3	High temperature storage	+85 °C × 1 000 h	± 2	22	0
-	storage				;
	Low temperature		*3		
4	storage	$-40 \ ^{\circ}\text{C} \times 1 \ 000 \ \text{h}$	± 2	22	0
			*3	for starting and the starting of the starting	
	Temperature	+85 °C × 85 %RH × 1 000 h	± 2	22	0
5	humidity storage	+85 °C × 85 %KH × 1 000 II	Ξ 2	24	v
			[*3		
6	Temperature cycle	-40 °C ⇔ + 85 °C	± 2	22	0
0.		30 min at each temp. 100 cycles			
	Resistance to	For convention reflow soldering furnace		1	
7	soldering heat	(3 times)	± 2	22	0
		Bend width reaches 3.0 mm and hold for	No peeling - off at a	1	
8	Substrate bending	$5 s \pm 1 s \times 1 time$	solder part	11	0
		Ref. IEC 60068-2-21	Soluci part		
	8	10 N press for 10 s \pm 1 s	No peeling - off at a		
9	Shear	Ref. IEC 60068-2-21	solder part	11	0
memerika	:		Down Part		
		10 N press for 10 s \pm 1 s	No peeling - off at a	1	
10	Pull - off	Ref. IEC 60068-2-21	solder part	11	0
				<u> </u>	
	0-14	Dip termination into solder bath at $+235 \text{ °C} \pm 10 \text{ °C}$ for 5 s	Termination must be 95 % covered	11	0
-11	Solderability	1	with fresh solder		v
	L	(Using Rosin Flux)	while mesh souce	1	L

Notes

1. *1 Each test done independently.

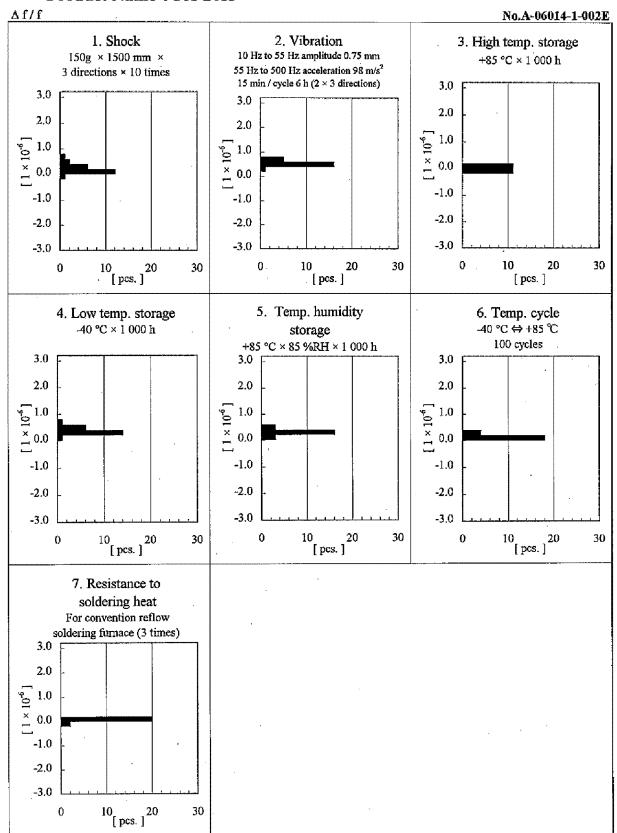
2. *2 Measuring 2 h to 24 h later leaving in room temperature after each test.

3. *3 Measuring 24 h later leaving in room temperature after each test.

1. Reflow 3 times

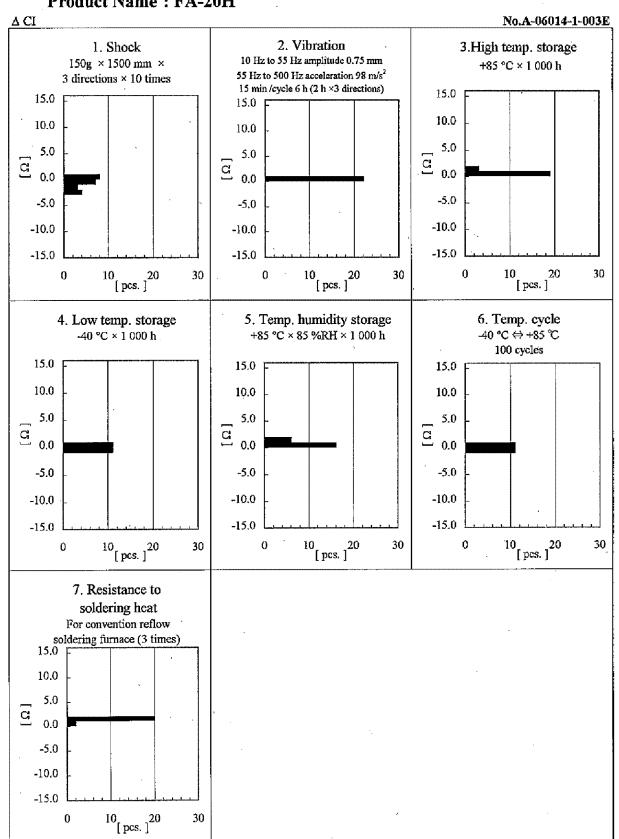
2. Initial value shall be after 24h at room temperature.

4. Shift series resistance at before above tests should be less than ± 20 % or less than ± 10 Ω .



Product Name : FA-20H

Qualification Data



Product Name : FA-20H

Qualification Data



ATTN : WKK Technology Limited

Quality and reliability data

No.ST14-234 Aug., 21, 2014 SEIKO EPSON CORP. TD • CS QUALITY ASSURANCE DEPARTMENT

Type : FA-20H

·Machine Model JEDEC JESD22-A115-A (C=200 pF;R=0 Ω) :> ± 100 Volt

·Human Body Model JESD22-A114-D (C=100 pF;R=1 500 Ω) :> \pm 500 Volt

Criterion : Frequency change rate exceeded $\pm 2 \times 10^{-6}$